CHIP COIL (CHIP INDUCTOR) for Consumer equipment & Industrial equipment LQP01HV

1. Scope

This reference specification applies to LQP01HV____02 series.

1.1 Specific applications:

- Power equipment: Products that can be used in power equipment such as renewable energy equipment, energy storage
 equipment and EV charging equipment and whose functions are not directly related to the protection of human life and
 property.
- Industrial equipment: Products that can be used in industrial equipment such as base stations, manufacturing equipment, industrial robotics equipment, and measurement equipment, and whose functions do not directly relate to the protection of human life and property.
- Medical equipment (GHTF Class C) *Except for Implant/surgery/auto injector: Products that can be used for medical
 equipment of Class C of the international classification class GHTF and whose malfunction is considered to pose a
 relatively high risk to the human body.
- Medical equipment (GHTF Class A and B): Products that can be used for medical equipment regulated by Class A and Class B of the international classification class GHTF and whose functions do not directly relate to the protection of human life and property.
- Consumer equipment: Products that can be used in consumer equipment such as home appliances, audio/visual equipment, communication equipment, information equipment, office equipment, and household robotics, and whose functions are not directly related to the protection of human life and property.

1.2 Unsuitable application:

Applications listed in "Limitation of applications" in this reference specification.

WE DISCLAIM ANY LOSS AND DAMAGES ARISING FROM OR IN CONNECTION WITH THE PRODUCTS INCLUDING BUT NOT LIMITED TO THE CASE SUCH LOSS AND DAMAGES CAUSED BY THE UNEXPECTED ACCIDENT, IN EVENT THAT THE PRODUCT IS APPLIED FOR THE PURPOSE WHICH IS SPECIFIED ABOVE AS THE UNSUITABLE APPLICATION FOR THE PRODUCT.

2. Part Numbering

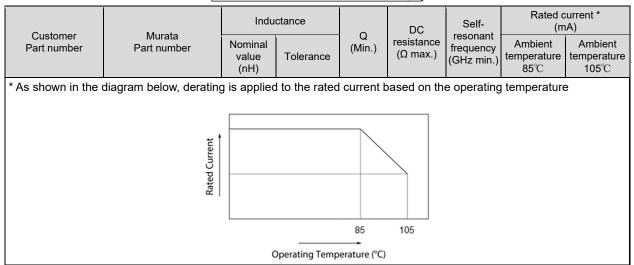
(Ex.)							
LQ	Р	01	HV	0N3	В	02	L
Product ID	Туре		Application and characteristic	Inductance	Tolerance	Category	Packaging L: taping

3. Part Number and Rating

Operating temperature range	-40°C to +105°C
Storage temperature range	-40°C to +105°C

0.1		Inductance		0	DC	Self-	Rated current * (mA)	
Customer Part number	Murata Part number	Nominal value (nH)	Tolerance	Q (Min.)	resistance (Ω max.)	resonant frequency (GHz min.)	Ambient temperature 85°C	Ambient temperature 105°C
	LQP01HV0N3B02L	0.3	±0.1nH	-	0.040	20	500	250
	LQP01HV0N4B02L	0.4	±0.1nH	-	0.070	20	500	250
	LQP01HV0N5B02L	0.5	±0.1nH	10	0.070	20	500	250
	LQP01HV0N6B02L	0.6	±0.1nH	10	0.070	20	500	250
	LQP01HV0N7B02L	0.7	±0.1nH	10	0.080	20	500	250
	LQP01HV0N8B02L	0.8	±0.1nH	10	0.110	20	500	250
	LQP01HV0N9B02L	0.9	±0.1nH	10	0.110	17	500	250
	LQP01HV1N0B02L	1.0	±0.1nH	10	0.110	17	400	200
	LQP01HV1N1B02L	1.1	±0.1nH	10	0.120	17	400	200
	LQP01HV1N2B02L	1.2	±0.1nH	10	0.140	17	400	200
	LQP01HV1N3B02L	1.3	±0.1nH	10	0.180	17	400	200

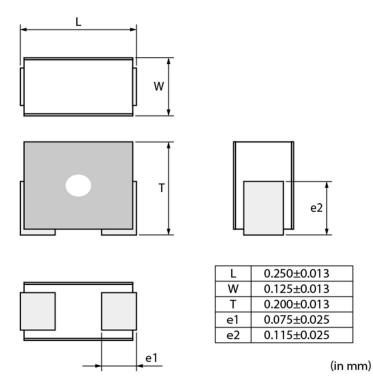
		Indu	ctance		o DC		Self- Rated current * (mA)	
Customer Part number	Murata Part number	Nominal value	Tolerance	Q (Min.)	resistance (Ω max.)	resonant frequency (GHz min.)	Ambient temperature	Ambient temperature
	LQP01HV1N4B02L	(nH) 1.4	±0.1nH	10	0.200	17	85℃ 400	105℃ 200
	LQP01HV1N4B02L	1.4		10	0.200	13	400	200
	LQP01HV1N6B02L	1.6	±0.1nH ±0.1nH	10	0.200	13	400	200
	LQP01HV1N7B02L	1.7	±0.1nH ±0.1nH	10	0.200	13	250	125
			-					
	LQP01HV1N8B02L LQP01HV1N9B02L	1.8 1.9	±0.1nH ±0.1nH	10 10	0.230 0.260	13 13	250 250	125 125
	LQP01HV1N9B02L	2.0	±0.111H ±0.1nH	10	0.200	13	250	125
	LQP01HV2N0B02L	2.0	±0.111H ±0.1nH	10	0.310	13	250	125
				10				
	LQP01HV2N2B02L LQP01HV2N3B02L	2.2	±0.1nH	10	0.370 0.370	13 13	250	125
			±0.1nH				250	125
	LQP01HV2N4B02L LQP01HV2N5B02L	2.4	±0.1nH ±0.1nH	10 10	0.420 0.420	13 13	250 250	125 125
	LQP01HV2N6B02L	2.6 2.7	±0.1nH	10 10	0.420	13	250	125
	LQP01HV2N7B02L		±0.1nH		0.420	13	200	100
	LQP01HV2N8B02L	2.8	±0.1nH	10	0.420	13	200	100
	LQP01HV2N9B02L	2.9	±0.1nH	10	0.420 0.420	13	180	90
	LQP01HV3N0B02L	3.0	±0.1nH	10		13	180	90
	LQP01HV3N1B02L	3.1	±0.1nH	10	0.460	13	180	90
	LQP01HV3N2B02L	3.2	±0.1nH	10	0.500	13	130	65
	LQP01HV3N3B02L	3.3	±0.1nH	10	0.530	11	130	65
	LQP01HV3N4B02L	3.4	±0.1nH	10	0.530	11	130	65
	LQP01HV3N5B02L	3.5	±0.1nH	10	0.540	11	130	65
	LQP01HV3N6B02L	3.6	±0.1nH	10	0.580	11	130	65
	LQP01HV3N7B02L	3.7	±0.1nH	10	0.620	11	130	65
	LQP01HV3N8B02L	3.8	±0.1nH	10	0.690	11	130	65
	LQP01HV3N9B02L	3.9	±0.1nH	10	0.790	11	130	65
	LQP01HV4N0B02L	4.0	±0.1nH	10	0.810	11	130	65
	LQP01HV4N1B02L	4.1	±0.1nH	10	0.880	11	130	65
	LQP01HV4N2B02L	4.2	±0.1nH	10	0.880	11	130	65
	LQP01HV4N3H02L	4.3	±3%	10	0.880	11	130	65
	LQP01HV4N7H02L	4.7	±3%	10	1.300	9	100	50
	LQP01HV5N1H02L LQP01HV5N6H02L	5.1	±3%	10	1.300	9	100	50
		5.6	±3%	10	1.300	9	100	50
	LQP01HV6N2H02L LQP01HV6N8H02L	6.2 6.8	±3% ±3%	10 10	1.500 1.600	7	100 100	50 50
	LQP01HV7N5H02L	7.5	±3% ±3%	10	1.650	7	70	35
	LQP01HV7N5H02L	8.2	±3% ±3%	10	2.000	7	70	35
	LQP01HV9N1H02L	9.1	±3% ±3%	10	2.000	6	70	35
	LQP01HV9N1H02L	10	±3% ±3%	10	2.300	6	70	35
	LQP01HV10NH02L	11	±3% ±3%	10	2.800	5	70	35
	LQP01HV11NH02L	12	±3% ±3%	9	2.800	5	70	35
	LQP01HV12NH02L	13	±3% ±3%	7	3.300	5	70	35
	LQP01HV15NH02L	15	±3% ±3%	7	3.700	5	70	35
							-	
	LQP01HV16NH02L	16	±3%	7	3.700	4	70	35



4. Testing Conditions

Unless otherwise specified	Temperature: ordinary temperature (15°C to 35°C) Humidity: ordinary humidity [25% to 85% (RH)]
In case of doubt	Temperature: 20°C±2°C Humidity: 60% to 70% (RH) Atmospheric pressure: 86 kPa to 106 kPa

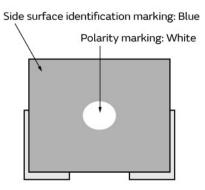
5. Appearance and Dimensions



Unit mass (typical value): 0.028mg



6. Marking



7. Electrical Performance

No.	Item	Specification	Test method
7.1	Inductance	Meet chapter 3 ratings.	Measuring equipment: Keysight E4991B or the equivalent Measuring frequency: 500MHz Measuring Condition: Measurement signal level: Approx. 0 dBm Electrical length: 0 mm Weight: 250g Measuring Fixture: KEYSIGHT 16198A Contact board: (KEYSIGHT: GuidePCA0201, 100 μm)
			Position the chip coil under test as shown in the measuring example below and connect it to the electrode by applying weight.
7.2	Q	Meet chapter 3 ratings.	Measurement example:
			Measuring method: see "Electrical performance: Measuring method for inductance/Q" in the Appendix.
7.3	DC resistance	Meet chapter 3 ratings.	Measuring equipment: digital multimeter
7.4	Self-resonant frequency	Meet chapter 3 ratings.	Measuring equipment: Keysight N5230A or the equivalent
7.5	Rated current	Temperature rise caused by self- generated heat shall be limited to 25°C max.	Apply the rated current specified in chapter 3 at ordinary temperature.



8. Mechanical Performance

The product is soldered on a substrate for test.(Except Solderability)

(Test shall be done using Flux, Solder and Soldering condition which are specified in chapter 12 except the case of being

specified special condition.)

No.	ed special condition Item	Specification	Test method
8.1	Shear test	No significant mechanical damage or no sign of electrode peeling off shall be observed.	Applying force: 0.5 N Holding time: 3±1 s Force application direction:
8.2	Bending test	No significant mechanical damage or no sign of electrode peeling off shall be observed.	Test substrate: glass-epoxy substrate (100 mm × 40 mm × 0.8 mm) Pressurizing speed: 1.0 mm/s Pressure jig: R340 Amount of bending: 1 mm Holding time: 30 s Pressure jig R340 F Deflection Product (in mm)
8.3	Vibration	Appearance shall have no significant mechanical damage.	Oscillation frequency: 10 Hz to 2000 Hz to 10 Hz/20 min Total amplitude: 1.5 mm or acceleration amplitude of 196 m/s², whichever is smaller Test time: 3 directions perpendicular to each other, 2 h for each direction (6 h in total)
8.4	Solderability	90% or more of the outer electrode shall be covered with new solder seamlessly.	Flux: Ethanol solution of rosin, 25(wt)% Pre-heating: 150°C/60 s Solder: Sn-3.0Ag-0.5Cu solder Solder temperature: 245°C±3°C Immersion time: 4 s

9. Environmental Performance

The product is soldered on a substrate for test.

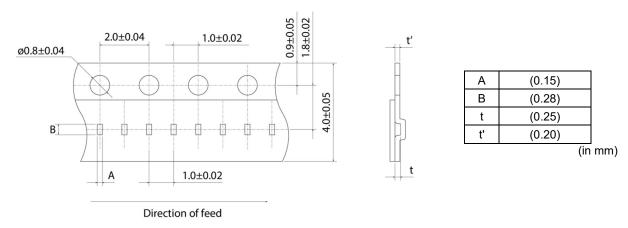
(Test shall be done using Flux, Solder and Soldering condition which are specified in chapter 12 except the case of being specified special condition.)

No.	Item	Specification	Test method
9.1	Heat resistance	Appearance: No significant mechanical damage shall be observed. Inductance change rate: within ±10%	Temperature: 105°C±2°C Test time: 1000 h (+48 h, -0 h) Post-treatment: left for 4 hours to 48 hours at room temperature.
9.2	Cold resistance	Appearance: No significant mechanical damage shall be observed. Inductance change rate: within ±10%	Temperature: -40°C±2°C Test time: 1000 h (+48 h, -0 h) Post-treatment: left for 4 hours to 48 hours at room temperature.
9.3	Humidity	Appearance: No significant mechanical damage shall be observed. Inductance change rate: within ±10%	Temperature: 40°C±2°C Humidity: 90%(RH) to 95% (RH) Test time: 1000 h (+48 h, -0 h) Post-treatment: left for 4 hours to 48 hours at room temperature.

No.	Item	Specification	Test method
9.4	Temperature cycle	damage shall be observed. Inductance change rate: within ±10%	Single cycle conditions: Step 1: -40°C (+0°C, -3°C), 30 min (+3 min, -0 min) Step 2: ordinary temperature, 3 min max. Step 3: +105°C (+3°C, -0°C), 30 min (+3 min, -0 min) Step 4: ordinary temperature, 3 min max. Number of testing: 10 cycles Post-treatment: left for 4 hours to 48 hours at room temperature.

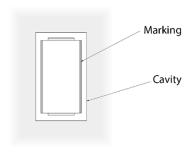
10. Specification of Packaging

10.1 Appearance and dimensions of tape (4 mm width/plastic tape)



^{*} The dimensions of the cavity are measured at its bottom.

■ Top view



Direction of feed

10.2 Taping specifications

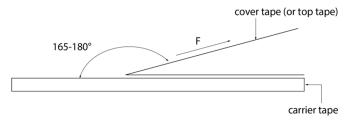
Packing quantity (Standard quantity)	40000 pcs/reel
Packing method	The products are placed in cavities of a carrier tape and sealed by a cover tape (top tape and bottom tape when the cavities of the carrier tape are punched type).
Feed hole position	The feed holes on the carrier tape are on the right side when the cover tape (top tape when the cavities of the carrier tape are punched type) is pulled toward the user.
Joint	The carrier tape and cover tape (top tape when the cavities of the carrier tape are punched type) are seamless.
Number of missing products	Number of missing products within 0.1% of the number per reel or 1 pc., whichever is greater, and are not continuous. The specified quantity per reel is kept.

10.3 Break down force of tape

Cover tape (or top tape)	5 N min.
Bottom tape (only when the cavities of the carrier tape are punched type)	5 N min.

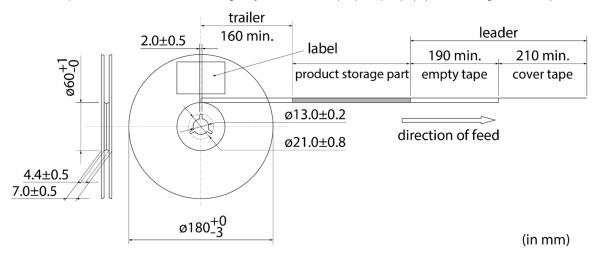
10.4 Peeling off force of tape

	-
Speed of peeling off	300 mm/min
Peeling off force	0.1 N to 0.7 N (The lower limit is for typical value.)



10.5 Dimensions of leader section, trailer section and reel

A vacant section is provided in the leader (start) section and trailer (end) section of the tape for the product. The leader section is further provided with an area consisting only of the cover tape (or top tape). (See the diagram below.)



10.6 Marking for reel

Customer part number, Murata part number, inspection number (*1), RoHS marking (*2), quantity, etc.

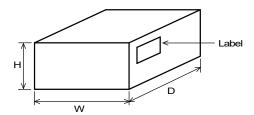
Odotomor part nambor, marata pe	trampor, inspection named (1), rearis marking (2), quartity, etc.
*1 Expression of inspection No.:	(1) Factory code
0000 ♦♦♦	(2) Date
(1) (2) (3)	First digit: year/last digit of year
	Second digit: month/Jan. to Sep.→1 to 9, Oct. to Dec.→O, N, D
	Third, Fourth digit: day
	(3) Serial No.
*2 Expression of RoHS marking:	(1) RoHS regulation conformity
ROHS- Y (△)	(2) Murata classification number
(1) (2)	
., .,	

10.7 Marking on outer box (corrugated box)

Customer name, purchasing order number, customer part number, Murata part number, RoHS marking (*2), quantity, etc.



10.8 Specification of outer box



Dimensions of outer box (mm)		Standard reel quantity in outer box (reel)	
W	D	Н	in outer box (reei)
186	186	93	10

^{*} Above outer box size is typical. It depends on a quantity of an order.

11. ACaution

11.1 Limitation of applications

The products listed in the reference specification (hereinafter the product(s) is called as the "Product(s)") are designed and manufactured for applications specified in the reference specification (hereinafter called as the "Specific Application"). We shall not warrant anything in connection with the Products including fitness, performance, adequateness, safety, or quality, in the case of applications listed in from (1) to (11) written at the end of this precautions, which may generally require high performance, function, quality, management of production or safety. Therefore, the Product shall be applied in compliance with the specific application.

WE DISCLAIM ANY LOSS AND DAMAGES ARISING FROM OR IN CONNECTION WITH THE PRODUCTS INCLUDING BUT NOT LIMITED TO THE CASE SUCH LOSS AND DAMAGES CAUSED BY THE UNEXPECTED ACCIDENT, IN EVENT THAT (i) THE PRODUCT IS APPLIED FOR THE PURPOSE WHICH IS NOT SPECIFIED AS THE SPECIFIC APPLICATION FOR THE PRODUCT, AND/OR (ii) THE PRODUCT IS APPLIED FOR ANY FOLLOWING APPLICATION PURPOSES FROM (1) TO (11) (EXCEPT THAT SUCH APPLICATION PURPOSE IS UNAMBIGUOUSLY SPECIFIED AS SPECIFIC APPLICATION FOR THE PRODUCT IN OUR CATALOG SPECIFICATION FORMS, DATASHEETS, OR OTHER DOCUMENTS OFFICIALLY ISSUED BY US*).

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- (4) Power plant control equipment
- (5) Medical equipment
- (6) Transportation equipment
- (7) Traffic control equipment
- (8) Disaster prevention/security equipment
- (9) Industrial data-processing equipment
- (10) Combustion/explosion control equipment
- (11) Equipment with complexity and/or required reliability equivalent to the applications listed in the above.

For exploring information of the Products which will be compatible with the particular purpose other than those specified in the reference specification, please contact our sales offices, distribution agents, or trading companies with which you make a deal, or via our web contact form.

Contact form: https://www.murata.com/contactform

* We may design and manufacture particular Products for applications listed in (1) to (11). Provided that, in such case we shall unambiguously specify such Specific Application in the reference specification without any exception. Therefore, any other documents and/or performances, whether exist or non-exist, shall not be deemed as the evidence to imply that we accept the applications listed in (1) to (11).

11.2 Precautions on rating

Avoid using in exceeded the rated temperature range, rated voltage, or rated current. Usage when the ratings are exceeded could lead to wire breakage, burning, or other serious fault.

11.3 Inrush current

If an inrush current (or pulse current or rush current) that significantly exceeds the rated current is applied to the product, overheating could occur, resulting in wire breakage, burning, or other serious fault.



12. Precautions for Use

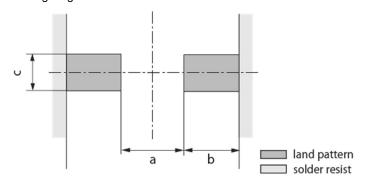
This product is for use only with reflow soldering. It is designed to be mounted by soldering. If you want to use other mounting method, for example, using a conductive adhesive, please consult us beforehand.

Also, if repeatedly subjected to temperature cycles or other thermal stress, due to the difference in the coefficient of thermal expansion with the mounting substrate, the solder (solder fillet part) in the mounting part may crack.

The occurrence of cracks due to thermal stress is affected by the size of the land where mounted, the solder volume, and the heat dissipation of the mounting substrate. Carefully design it when a large change in ambient temperature is assumed.

12.1 Land dimensions

The following diagram shows the recommended land dimensions for reflow soldering.



0.100
0.100 to 0.125
0.100
(in r

m)

When C dimension is larger than the standard land dimension, the product easily tilts.

12.2 Flux and solder used

Flux	 Use a rosin-based flux. Do not use a highly acidic flux with a halide content exceeding 0.2 mass% (chlorine conversion value). Do not use a water-soluble flux.
Solder	 Use Sn-3.0Ag-0.5Cu solder (Type 6). Standard thickness of solder paste: 50 μm

If you want to use a flux other than the above, please consult our technical department.

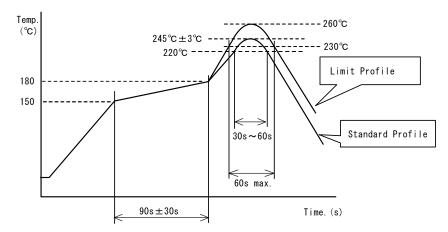
12.3 Soldering conditions (reflow)

· Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 100°C max.

Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max. Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of product quality.

• Standard soldering profile and the limit soldering profile is as follows.

The excessive limit soldering conditions may cause leaching of the electrode and/or resulting in the deterioration of product quality.



	Standard profile	Limit profile
Pre-heating	150°C to 180°C/90 s±30 s	150°C to 180°C/90 s±30 s
Heating	Above 220°C/30 s to 60 s	Above 230°C/60 s max.
Peak temperature	245°C±3°C	260°C/10 s
Number of reflow cycles	2 times	2 times



12.4 Reworking with soldering iron

Do not perform reworking with a soldering iron on this product.

12.5 Solder volume

Solder shall be used not to increase the volume too much.

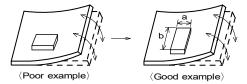
An increased solder volume increases mechanical stress on the product. Exceeding solder volume may cause the failure of mechanical or electrical performance.

12.6 Product's location

The following shall be considered when designing and laying out PCBs.

(1) PCB shall be designed so that products are not subject to mechanical stress due to warping the board. [Products direction]

Products shall be located in the sideways direction (length: a < b) to the mechanical stress.



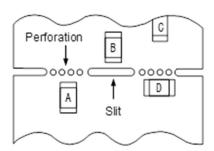
(2) Components location on PCB separation

It is effective to implement the following measures, to reduce stress in separating the board.

It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

Contents of measures	Stress level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D*1
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C

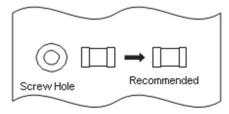
^{*1} A > D is valid when stress is added vertically to the perforation as with hand separation. If a cutting disc is used, stress will be diagonal to the PCB, therefore A > D is invalid.



(3) Mounting components near screw holes

When a component is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw.

Mount the component in a position as far away from the screw holes as possible.





12.7 Handling of substrate

(1) The stress applied to the chip varies depending on the material and construction of the mounted substrate. If the coefficients of thermal expansion for the substrate and chip vary significantly, the difference in thermal expansion and shrinkage could cause cracks to form in the chip.

We assume that the products are mounted on glass-epoxy substrate. Assessment has not been conducted on substrates where the coefficient of thermal expansion varies significantly from glass-epoxy substrates. If mounting on these substrates, be sure to conduct full assessments before use.

(2) After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.

Also, if mounting on flexible substrates, excessive mechanical stress could be applied to the chip by even slight bending or twisting when handling this substrate, and so please conduct full assessments before use.





12.8 Cleaning

Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Before starting your production process, test your cleaning equipment / process to insure it does not degrade this product.

12.9 Storage and transportation

	•
Storage period	Use the product within 6 months after delivery. If you do not use the product for more than 6 months, check solderability before using it.
Storage conditions	 The products shall be stored in a room not subject to rapid changes in temperature and humidity. The recommended temperature range is 5°C to +40°C (The temperature recommendation is less than 30°C). The recommended relative humidity range is 20% to 70%. Keeping the product in corrosive gases, such as sulfur, chlorine gas or acid may cause the poor solderability. Do not place the products directly on the floor; they should be placed on a palette so that they are not affected by humidity or dust. Avoid keeping the products in a place exposed to direct sunlight, heat or vibration. Do not keep products in bulk packaging. Bulk storage could result in collisions between the products or between the products and other parts, resulting in chipping or wire breakage. Avoid storing the product by itself bare (i.e. exposed directly to air).
Transportation	Excessive vibration and impact reduces the reliability of the products. Exercise caution when handling the products.

12.10 Resin coating (including moisture-proof coating)

When the product is coated/molded with resin, its electrical characteristics may change.

A wire breakage issue may occur by mechanical stress caused by the resin, amount/cured shape of resin, or operating condition etc.

Some resins contain impurities or hydrolyzable chlorine, which could result in corrosion of the conducting materials, leading to wire breakage.

So, please pay your careful attention when you select resin in case of coating/molding the products with the resin.

Prior to use the coating resin, please make sure no reliability issue is observed by evaluating products mounted on your board.

12.11 Mounting conditions

Check the mounting condition before using.

Using mounting conditions (nozzles, equipment conditions, etc.) that are not suitable for products may lead to pick up errors, misalignment, or damage to the product.

12.12 Operating environment

Do not use this product under the following environmental conditions as it may cause deterioration of product quality.

- (1) In the corrodible atmosphere such as acidic gases, alkaline gases, chlorine, sulfur gases, organic gases and etc. (the sea breeze, Cl2, H2S, NH3, SO2, NO2, etc)
- (2) In the atmosphere where liquid such as organic solvent, may splash on the products.
- (3) In the atmosphere where the temperature/humidity changes rapidly and it is easy to dew.



12.13 Mounting density

If this product is placed near heat-generating products, be sure to implement sufficient heat-dissipating measures. If this product is subjected to a significant amount of heat from other products, this could adversely affect product quality, resulting in a circuit malfunction or failure of the mounted section. Also, be sure that the product is used in a manner so that the heat that the product is subjected to from other products does not exceed the upper limit of the rated operating temperature for the product.

13. **A**Note

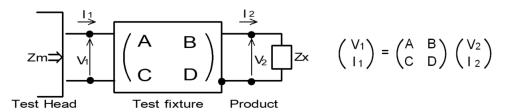
- (1) Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2) You are requested not to use our product deviating from the reference specifications.
- (3) The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

Appendix

Electrical performance: Measuring method for inductance/Q (Q measurement is applicable only when the Q value is included in the rating table.)

Perform measurement using the method described below. (Perform correction for the error deriving from the measuring terminal.)

(1) Residual elements and stray elements of the measuring terminal can be expressed by the F parameter for the 2-pole terminal as shown in the figure below.



(2) The product's impedance value (Zx) and measured impedance value (Zm) can be expressed as shown below, by using the respective current and voltage for input/output.

$$Zm = \frac{V_1}{I_1}$$
 $Zx = \frac{V_2}{I_2}$

(3) Thus, the relationship between the product's impedance value (Zx) and measured impedance value (Zm) is as follows.

	Here α = [, D/A = 1			
	β = E	3/D = Zsm - (1 - Yom Zsm) Zss		
$Zx=\alpha \frac{Zm-\beta}{1-7m\Gamma}$	Γ = C	C/A = Yom			
ZX-α <u>1-ZmΓ</u>					
	Zsm:	measured in	npedance of short	chip	
	Zss:	residual impe	edance of short ch	ip (0.19 nH)	
	Yom:	measured a	dmittance when m	easuring terminal i	s open

(4) Calculate inductance Lx and Qx using the equations shown below.

|--|